

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSVI)

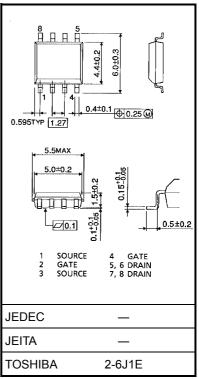
TPC8201

Lithium Ion Battery Applications Portable Equipment Applications Notebook PCs

- Low drain-source ON resistance $: R_{DS} (ON) = 37 \text{ m}\Omega (typ.)$
- High forward transfer admittance $: |Y_{fs}| = 6 S (typ.)$
- Low leakage current $: I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 30 \ V)$
- Enhancement-mode : $V_{th} = 0.8 \sim 2.0 V (V_{DS} = 10 V, I_D = 1 mA)$

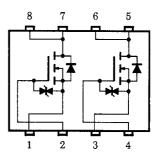
Maximum Ratings (Ta = 25°C)

Char	acteristics	Symbol	Rating	Unit	
Drain-source vol	tage	V _{DSS}	30	V	
Drain-gate voltag	ge (R _{GS} = 20kΩ)	V _{DGR}	30	V	
Gate-source volt	age	V _{GSS}	±20	V	
Ducin	D C (Note 1)	ID	5	А	
Drain curren	Pulse (Note 1)	I _{DP}	20	A	
Drain power dissipation (t = 10s) (Note 2a)	Single-device operation (Note 3a)	P _{D (1)}	1.5	w	
	Single-device value at dual operation (Note 3b)	P _{D(2)}	1.1		
Drain power dissipation (t = 10s) (Note 2b)	Single-device operation (Note 3a)	P _{D (1)}	0.75	W	
	Single-device value at dual operation (Note 3b)	P _{D (2)}	0.45		
Single pulse ava	lanche energy (Note 4)	E _{AS}	32.5	mJ	
Avalanche currei	nt	I _{AR}	5	А	
Repetitive avalar Single-device va		E _{AR}	0.1	mJ	
Channel tempera	ature	T _{ch}	150 °(
Storage tempera	ture range	T _{stg}	-55~150	°C	



Weight: 0.08 g (typ.)

Circuit Configuration



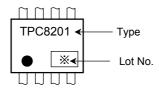
Note: For (Note 1), (Note 2a), (Note 2b), (Note 3a), (Note 3b), (Note 4) and (Note 5) please refer to the next page. This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm

Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Thermal resistance, shannel to embient	Single-device operation (Note 3a)	R _{th (ch-a)} (1)	83.3		
Thermal resistance, channel to ambient (t = 10s) (Note 2a)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	114	°C/W	
Thermal resistance, channel to ambient	Single-device operation (Note 3a)	R _{th (ch-a)} (1)	167	C/vv	
(t = 10s) (Note 2b)	Single-device value at dual operation (Note 3b)	R _{th (ch-a) (2)}	278		

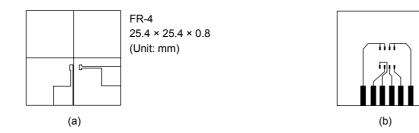
Marking (Note 6)



Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

- a) Device mounted on a glass-epoxy board (a)
- b) Device mounted on a glass-epoxy board (b)



FR-4 25.4 × 25.4 × 0.8 (Unit: mm)

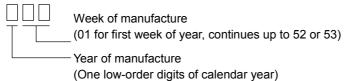
Note 3:

- a) The power dissipation and thermal resistance values are shown for a single device (During single-device operation, power is only applied to one device.).
- b) The power dissipation and thermal resistance values are shown for a single device (During dual operation, power is evenly applied to both devices.).

Note 4: V_{DD} = 16 V, T_{ch} = 25°C (initial), L = 1.0 mH, R_G = 25 Ω , I_{AR} = 6 A

Note 5: Repetitive rating; pulse width limited by maximum channel temperature.

- Note 6: \bullet on lower right of the marking indicates Pin 1.
 - % Weekly code:(Three digits)



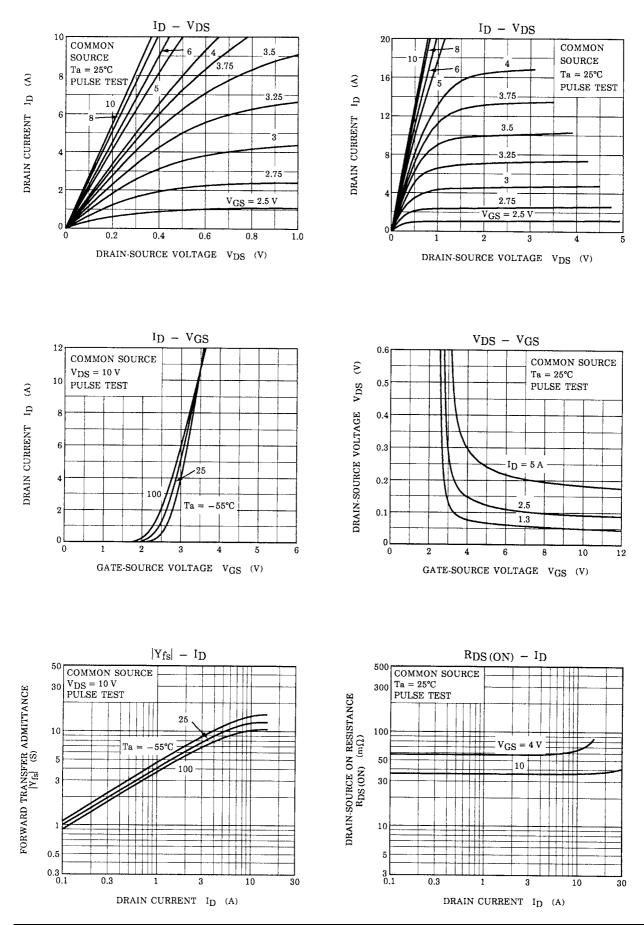
Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_		±10	μA
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V			10	μA
Drain-source br	eakdown voltage	V _(BR) DSS	I _D = 10 mA, V _{GS} = 0 V	30		_	V
Gate threshold v	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	0.8	_	2.0	V
Drain-source O	Nrosistanco	R _{DS (ON)}	V _{GS} = 4 V, I _D = 2.5 A	_	- 58 80 - 37 50 3 6 - 475 - 85 - 270		mΩ
	IN TESIStance	R _{DS (ON)}	V _{GS} = 10 V, I _D = 2.5 A	_	37	50	mΩ
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2.5 A	3	6	—	S
Input capacitance	e	C _{iss}			475	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	85	_	pF
Output capacitance		Coss			270	_	
Drain-source bre Gate threshold vo Drain-source ON Forward transfer Input capacitance Reverse transfer Output capacitan Switching time Total gate charge plus gate-drain)	Rise time	tr	$V_{GS} \stackrel{10 \text{ V}}{}_{0 \text{ V}} \stackrel{I_{D} = 2.5 \text{ A}}{}_{VOUT} \stackrel{V_{OUT}}{}_{R_{L}} = 6 \Omega$ $V_{DD} = 15 \text{ V}$ $Duty \leq 1\%, t_{W} = 10 \mu \text{s}$	_	10	_	
	Turn-on time	t _{on}		-	16	_	20
	Fall time	t _f		_	13	_	ns
	Turn-off time	t _{off}		_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg			16	_	
Gate-source charge		Q _{gs}	V _{DD} ≈ 24 V, V _{GS} = 10 V, I _D = 5 A	—	11	—	nC
Gate-drain ("miller") charge		Q _{gd}]		5	—	

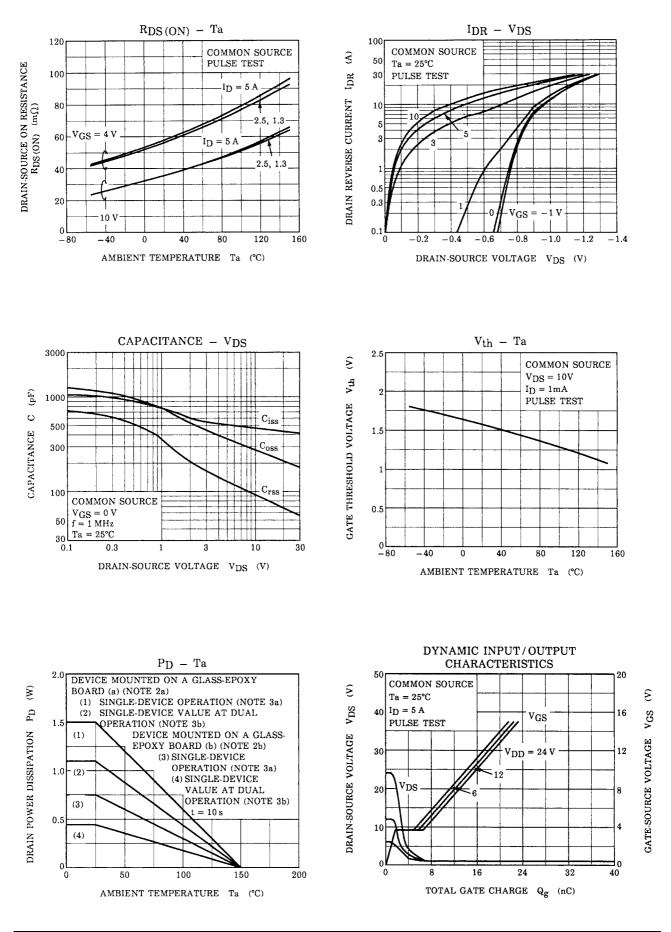
Source–Drain Ratings and Characteristics (Ta = 25°C)

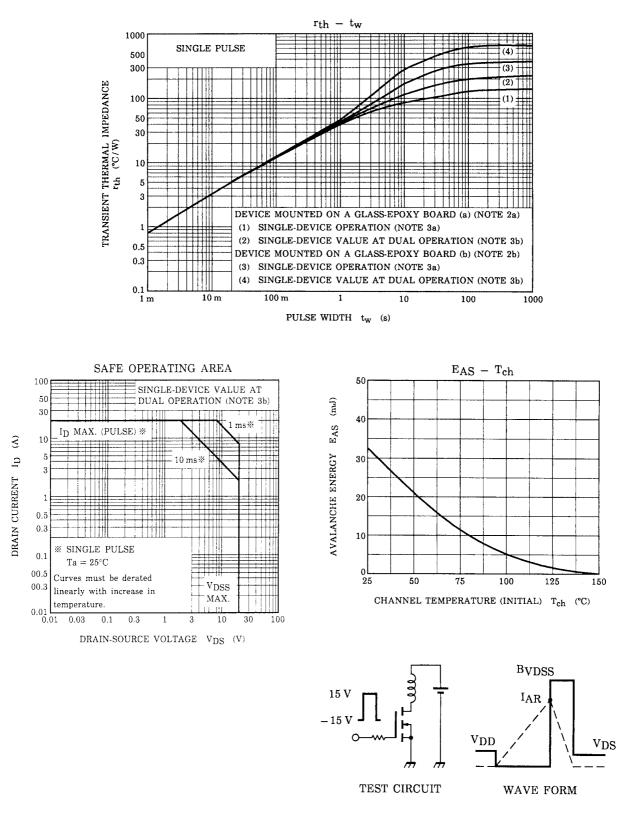
Charact	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I _{DRP}	_	_	_	20	А
Forward voltage	(diode)	V _{DSF}	I _{DR} = 5 A, V _{GS} = 0 V	_	_	-1.2	V

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 $\begin{array}{l} T_{ch} = 25^\circ C \ (Initial) \\ Peak \ I_{AR} = 5 \ A, \ R_G = 25 \ \Omega \quad E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right) \\ V_{DD} = 24 \ V, \ L = 1.0 \ mH \end{array}$

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